


<b>Search Notes</b>  	<b>Application/Control No.</b>  10584094	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Jacob K Ackun Jr.	<b>Art Unit</b>  3728

SEARCHED			
Class	Subclass	Date	Examiner
206	219, 220, 221	8/11/10	J.A.
222	524.1, 525	3/19/11	J.A.
215	Dig 8	3/19/11	J.A.

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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